

July 1989 Revised August 1999

74F640 • 74F645 Octal Bus Transceiver with 3-STATE Outputs

General Description

These devices are octal bus transceivers designed for asynchronous two-way data flow between the A and B busses. Both busses are capable of sinking 64 mA, have 3-STATE outputs, and a common output enable pin. The direction of data flow is determined by the transmit/receive (T/\overline{R}) input. The 74F645 is a high speed/low power version of the 74F245. The 74F640 is an inverting option of the 74F645.

Features

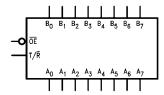
- Designed for asynchronous two-way data flow between busses
- Outputs sink 64 mA
- Transmit/receive (T/R) input controls the direction of data flow
- 74F645 is a lower power, faster version of the 74F245
- 74F640 is an inverting option of the 74F645

Ordering Code:

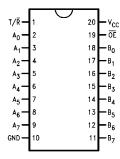
Order Number	Package Number	Package Description
74F640SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide
74F640PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
74F645PC	N20A	20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Logic Symbol



Connection Diagram



Unit Loading/Fan Out

Pin Names	Description	U.L.	Input I _{IH} /I _{IL}	
	Description	HIGH/LOW	Output I _{OH} /I _{OL}	
ŌĒ	Output Enable Input (Active LOW)	1.0/1.0	20 μA/-0.6 mA	
T/R	Transmit/Receive Input	1.0/1.0	20 μA/-0.6 mA	
A ₀ -A ₇	Side A Inputs or	3.5/0.667	70 μA/–0.4 mA	
	3-STATE Outputs	600/106.6	−12 mA/64 mA	
B ₀ –B ₇	Side B Inputs or	3.5/0.667	70 μA/-0.4 mA	
	3-STATE Outputs	600/106.6	−12 mA/64 mA	

Functional Description

The output enable (\overline{OE}) is active LOW. If the device is disabled $(\overline{OE}$ HIGH), the outputs are in the high impedance state. The transmit/receive input (T/\overline{R}) controls whether data is transmitted from the \underline{A} bus to the B bus or from the B bus to the A bus. When T/\overline{R} is LOW, B data is sent to the A bus. If T/\overline{R} is HIGH, A data is sent to the B bus.

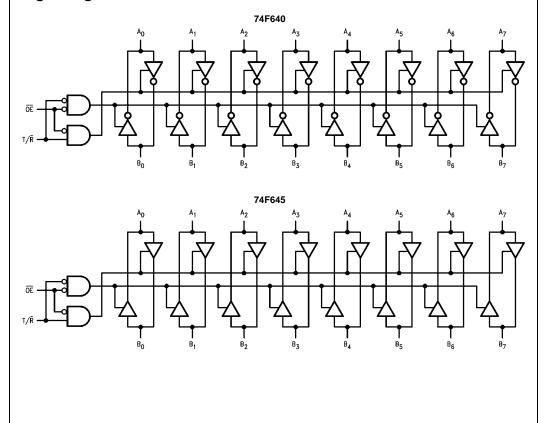
Function Table

Inputs		Outputs				
OE	T/R	74F640	74F645			
L	L	Bus B data to Bus A	Bus B data to Bus A			
L	Н	Bus A data to Bus B	Bus A data to Bus B			
Н	Χ	Z	Z			

- H = HIGH Voltage Level

- L = LOW Voltage Level
 X = Don't Care
 Z = High Impedance State

Logic Diagram



Absolute Maximum Ratings(Note 1)

 $\begin{array}{ll} \mbox{Storage Temperature} & -65^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{Ambient Temperature under Bias} & -55^{\circ}\mbox{C to } +125^{\circ}\mbox{C} \\ \end{array}$

Junction Temperature under Bias -55° C to $+150^{\circ}$ C V_{CC} Pin Potential to Ground Pin -0.5V to +7.0V

Voltage Applied to Output in HIGH State (with $V_{CC} = 0V$)

 $\begin{array}{ll} \mbox{Standard Output} & -0.5\mbox{V to V}_{\mbox{CC}} \\ \mbox{3-STATE Output} & -0.5\mbox{V to } +5.5\mbox{V} \end{array}$

Current Applied to Output

 $\label{eq:lower_lower} \mbox{in LOW State (Max)} \qquad \mbox{twice the rated $I_{\rm OL}$ (mA)} \\ \mbox{ESD Last Passing Voltage (Min)} \qquad \mbox{4000V}$

Recommended Operating Conditions

Free Air Ambient Temperature 0° C to $+70^{\circ}$ C Supply Voltage +4.5V to +5.5V

Note 1: Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

DC Electrical Characteristics

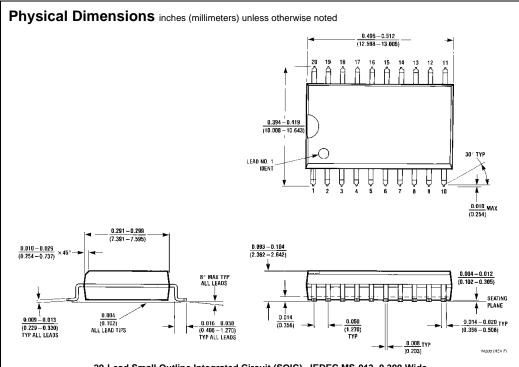
Symbol	Parameter	Min	Тур	Max	Units	v _{cc}	Conditions
V _{IH}	Input HIGH Voltage	2.0			V		Recognized as a HIGH Signal
V _{IL}	Input LOW Voltage			0.8	V		Recognized as a LOW Signal
V _{CD}	Input Clamp Diode Voltage			-1.2	V	Min	I _{IN} = -18 mA (Non I/O Pins)
V _{OH}	Output HIGH 10% V _{CC}	2.0			V	Min	$I_{OH} = -15 \text{ mA } (A_n, B_n)$
V _{OL}	Output LOW 10% V _{CC}			0.55	V	Min	I _{OL} = 64 mA (A _n , B _n)
I _{IH}	Input HIGH Current			5.0	μА	Max	V _{IN} = 2.7V (Non I/O Pins)
I _{BVI}	Input HIGH Current Breakdown Test			7.0	μА	Max	V _{IN} = 7.0V (Non I/O Pins)
I _{BVIT}	Input HIGH Current Breakdown (I/O)			0.5	mA	Max	$V_{IN} = 5.5V (A_n, B_n)$
I _{CEX}	Output HIGH Leakage Current			50	μА	Max	V _{OUT} = V _{CC}
V_{ID}	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu A$ All Other Pins Grounded
I _{OD}	Output Leakage Circuit Current			3.75	μА	0.0	V _{IOD} = 150 mV All Other Pins Grounded
I _{IL}	Input LOW Current			-0.6	mA	Max	V _{IN} = 0.5V (Non I/O Pins)
I _{IH} + I _{OZH}	Output Leakage Current			70	μΑ	Max	$V_{OUT} = 2.7V (A_n, B_n)$
I _{IL} + I _{OZL}	Output Leakage Current			-650	μΑ	Max	$V_{OUT} = 0.5V (A_n, B_n)$
los	Output Short-Circuit Current	-100		-225	mA	Max	V _{OUT} = 0V
I _{ZZ}	Bus Drainage Test			500	μΑ	0.0V	V _{OUT} = 5.25
I _{CCH}	Power Supply Current (74F640)			80	mA	Max	$V_O = HIGH, V_{IN} = 0.2V$
I _{CCL}	Power Supply Current (74F640)			80	mA	Max	$V_O = LOW$
I _{CCZ}	Power Supply Current (74F640)			96	mA	Max	V _O = HIGH Z
I _{CCH}	Power Supply Current (74F645)			65	mA	Max	V _O = HIGH
I _{CCL}	Power Supply Current (74F645)			80	mA	Max	$V_O = LOW, V_{IN} = 0.2V$
I _{CCZ}	Power Supply Current (74F645)			90	mA	Max	V _O = HIGH Z

AC Electrical Characteristics 74F640

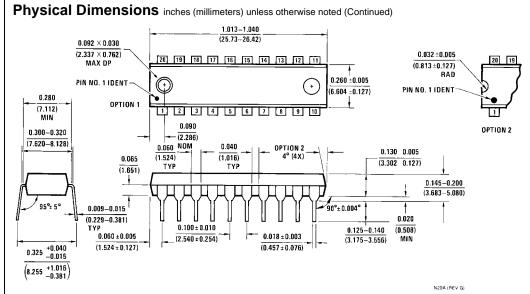
		$T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to $+70$ °C $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$		Units
Symbol	Parameter						
t _{PLH}	Propagation Delay	2.5		7.5	2.0	8.0	ns
t _{PHL}	A Input to B Output	2.0		7.0	2.0	7.0	115
t _{PLH}	Propagation Delay	2.5		7.5	2.0	8.0	ns
t _{PHL}	B Input to A Output	2.0		7.0	2.0	7.0	115
t _{PZH}	Enable Time	2.5		7.5	2.0	9.0	ns
t _{PZL}	OE Input to A Output	2.5		8.0	2.0	8.5	
t _{PHZ}	Disable Time	1.5		7.0	1.0	7.5	
t _{PLZ}	OE Input to A Output	1.5		6.0	1.5	6.0	
t _{PZH}	Enable Time	2.5		7.5	2.0	9.0	ns
t _{PZL}	OE Input to B Output	2.5		8.0	2.0	8.5	
t _{PHZ}	Disable Time	1.5		7.0	1.0	7.5	1
t _{PLZ}	OE Input to B Output	1.5		6.0	1.5	6.0	

AC Electrical Characteristics 74F645

Symbol	Parameter		$T_A = +25^{\circ}\text{C}$ $V_{CC} = +5.0\text{V}$ $C_L = 50 \text{ pF}$			$T_A = 0$ °C to +70°C $V_{CC} = +5.0$ V $C_L = 50$ pF	
		Min	Тур	Max	Min	Max	
t _{PLH}	Propagation Delay	1.5		6.0	1.5	7.0	ns
t _{PHL}	A Input to B Output	2.0		7.0	2.0	7.5	115
t _{PLH}	Propagation Delay	1.5		6.0	1.5	7.0	ns
t _{PHL}	B Input to A Output	2.0		7.0	2.0	7.5	118
t _{PZH}	Enable Time	2.5		8.0	2.0	9.0	ns
t_{PZL}	OE Input to A Output	2.5		8.5	2.0	8.5	
t _{PHZ}	Disable Time	1.5		7.0	1.0	8.0	
t_{PLZ}	OE Input to A Output	1.0		5.5	1.0	5.5	
t _{PZH}	Enable Time	2.5		7.5	2.0	9.5	ns
t_{PZL}	OE Input to B Output	2.5		8.5	2.5	9.0	
t _{PHZ}	Disable Time	1.5		6.5	1.0	7.5	
t_{PLZ}	OE Input to B Output	1.0		5.5	1.0	5.5	



20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide Package Number M20B



20-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide Package Number N20A

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